

<b>Notice of References Cited</b>	Application/Control No. 10/753,976	Applicant(s)/Patent Under Reexamination LIEW ET AL.	
	Examiner John F. Ramirez	Art Unit 3737	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,247,934	09-1993	Wehrli et al.	600/410
*	B	US-5,335,260	08-1994	Arnold, Ben A.	378/207
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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